This family of CMOS analog switches offers low resistance switching performance for analog voltages up to the supply rails and for signal currents up to 80 mA . "ON" resistance is low and stays reasonably constant over the full range of operating signal voltage and current. ron remains exceptionally constant for input voltages between +5 V and -5 V and currents up to 50 mA . Switch impedance also changes very little over temperature, particularly between $0^{\circ} \mathrm{C}$ and $75^{\circ} \mathrm{C}$. $\mathrm{r}_{\mathrm{ON}}$ is nominally $25 \Omega$ for $\mathrm{HI}-5049$ and $\mathrm{HI}-5051$ and $50 \Omega$ for $\mathrm{HI}-5042$ through $\mathrm{HI}-5047$.

All devices provide break-before-make switching and are TTL and CMOS compatible for maximum application versatility. Performance is further enhanced by Dielectric Isolation processing which insures latch-free operation with very low input and output leakage currents ( 0.8 nA at $25^{\circ} \mathrm{C}$ ). This family of switches also features very low power operation $\left(1.5 \mathrm{~mW}\right.$ at $\left.25^{\circ} \mathrm{C}\right)$.

There are 7 devices in this switch series which are differentiated by type of switch action and value of ron (see Functional Description Table). The HI-504X and HI-505X series switches can directly replace IH-5040 series devices, and are functionally compatible with the DG180 and DG190 family

## Features

- Wide Analog Signal Range . . . . . . . . . . . . . . . . . . . $\pm 15 \mathrm{~V}$
- Low "ON" Resistance . . . . . . . . . . . . . . . . . . . . . . . . . . $25 \Omega$
- High Current Capability . . . . . . . . . . . . . . . . . . . . . . 80mA
- Break-Before-Make Switching
- Turn-On Time 370ns
- Turn-Off Time . . . . . . . . . . . . . . . . . . . . . . . . . . . . 280ns
- No Latch-Up
- Input MOS Gates are Protected from Electrostatic Discharge
- DTL, TTL, CMOS, PMOS Compatible
- Pb-Free Available (RoHS Compliant)


## Applications

- High Frequency Switching
- Sample and Hold
- Digital Filters
- Operational Amplifier Gain Switching


## Functional Diagram



## Functional Description

| PART NUMBER | TYPE | ron |
| :--- | :--- | :---: |
| HI-5042 | SPDT | $50 \Omega$ |
| HI-5043 | Dual SPDT | $50 \Omega$ |
| HI-5047 | 4 PST | $50 \Omega$ |
| HI-5049 | Dual DPST | $25 \Omega$ |
| HI-5051 | Dual SPDT | $25 \Omega$ |

## Ordering Information

| PART NUMBER | TEMP. RANGE ( ${ }^{\circ} \mathrm{C}$ ) | PACKAGE | PKG. DWG. \# |
| :---: | :---: | :---: | :---: |
| HI1-5042-2 | -55 to 125 | 16 Ld CERDIP | F16.3 |
| HI1-5043-2 | -55 to 125 | 16 Ld CERDIP | F16.3 |
| HI1-5043-5 | 0 to 75 | 16 Ld CERDIP | F16.3 |
| HI3-5043-5 | 0 to 75 | 16 Ld PDIP | E16.3 |
| $\begin{aligned} & \text { HI3-5043-5Z } \\ & \text { (See Note) } \end{aligned}$ | 0 to 75 | 16 Ld PDIP* (Pb-free) | F16.3 |
| HI9P5043-5 | 0 to 75 | 16 Ld SOIC | M16.15 |
| HI9P5043-5Z (See Note) | 0 to 75 | $\begin{aligned} & 16 \text { Ld SOIC } \\ & \text { (Pb-free) } \end{aligned}$ | M16.15 |
| HI1-5047-5 | 0 to 75 | 16 Ld CERDIP | F16.3 |
| HI1-5049-5 | 0 to 75 | 16 Ld CERDIP | F16.3 |
| HI1-5051-2 | -55 to 125 | 16 Ld CERDIP | F16.3 |
| HI1-5051-5 | 0 to 75 | 16 Ld CERDIP | F16.3 |
| HI3-5051-5 | 0 to 75 | 16 Ld PDIP | E16.3 |
| HI3-5051-5Z (No longer available, recommended replacement: HI9P5051-9Z (See Note) | 0 to 75 | 16 Ld PDIP * (Pb-free) | E16.3 |
| HI9P5051-9 | -40 to 85 | 16 Ld SOIC | M16.15 |
| HI9P5051-9Z (See Note) | -40 to 85 | 16 Ld SOIC (Pb-free) | M16.15 |

*Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.
NOTE: Intersil Pb-free products employ special Pb-free material sets; molding compounds/die attach materials and 100\% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb -free soldering operations. Intersil Pb -free products are MSL classified at Pb -free peak reflow temperatures that meet or exceed the Pb -free requirements of IPC/JEDEC J STD-020.

Pinouts (SWITCHES SHOWN FOR LOGIC "0" INPUT)

## Single Control



NOTE: Unused pins may be internally connected. Ground all unused pins.

## Pinouts (SWITCHES SHOWN FOR LOGIC "0" INPUT)

 Dual ControlDUAL SPDT
HI-5043 (50 ), HI-5051 (25 $)$


DUAL DPST
HI-5049 (25 $)$


NOTE: Unused pins may be internally connected. Ground all unused pins.

Switch Functions (SWITCHES SHOWN FOR LOGIC "1" INPUT)


4PST
HI-5047 (50 $)$


DUAL DPST
HI-5049 (25ת)


DUAL SPDT
HI-5051 (25ת)


## Schematic Diagrams



NOTE: Connect $\mathrm{V}+$ to $\mathrm{V}_{\mathrm{L}}$ for minimizing power consumption when driving from CMOS circuits.
TTL/CMOS REFERENCE CIRCUIT (NOTE)


NOTE: All N -Channel bodies to V -, all P -Channel bodies to $\mathrm{V}+$ except as shown.
DIGITAL INPUT BUFFER AND LEVEL SHIFTER

## Absolute Maximum Ratings

Supply Voltage (V+ to V-). . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 36V
$V_{R}$ to Ground. . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . + +, V-
Digital and Analog Input Voltage . . . . . . . . . . . . (V+) +4 V to (V-) -4 V
Analog Current (S to D) Continuous . . . . . . . . . . . . . . . . . . . . 30mA
Analog Current (S to D) Peak . . . . . . . . . . . . . . . . . . . . . . . . . . 80mA

## Operating Conditions

Temperature Range

| HI-50XX-2. | $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ |
| :---: | :---: |
| HI-50XX-5 | $0^{\circ} \mathrm{C}$ to $75^{\circ} \mathrm{C}$ |
| HI-50XX-9 | $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ |

## Thermal Information

$\begin{array}{ccc}\text { Thermal Resistance (Typical, Note 1) } & \theta_{\mathrm{JA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right) & \theta_{\mathrm{JC}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right) \\ \text { CERDIP Package. .............. } & 75 & 22 \\ \text { SOIC Package ................. } & 110 & \text { N/A } \\ \text { PDIP Package }{ }^{*} \ldots \ldots . \ldots . \ldots \ldots . & 90 & \text { N/A }\end{array}$
Maximum Junction Temperature
Plastic Packages . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . $150^{\circ} \mathrm{C}$
Ceramic Packages . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . $175^{\circ} \mathrm{C}$
Maximum Storage Temperature. . . . . . . . . . . . . . . . $65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
Maximum Lead Temperature (Soldering 10s) . . . . . . . . . . . . $300^{\circ} \mathrm{C}$ (SOIC - Lead Tips Only)
*Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $\theta_{\mathrm{JA}}$ is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications Supplies $=+15 \mathrm{~V},-15 \mathrm{~V} ; \mathrm{V}_{\mathrm{R}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{AH}}$ (Logic Level High) $=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{AL}}$ (Logic Level Low) $=0.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{L}}=5 \mathrm{~V}$, Unless Otherwise Specified. For Test Conditions, Consult Performance Characteristics, Unused Pins are Grounded

| PARAMETER | TEST CONDITIONS | $\begin{gathered} \text { TEMP } \\ \left({ }^{\circ} \mathrm{C}\right) \end{gathered}$ | -2 |  |  | -5, -9 |  |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | TYP | MAX |  |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |  |  |  |
| Switch ON Time, ton | (Note 5) | 25 | - | 370 | 500 | - | 370 | 500 | ns |
| Switch OFF Time, toff | (Note 5) | 25 | - | 280 | 500 | - | 280 | 500 | ns |
| Charge Injection, Q | (Note 3) | 25 | - | 5 | 20 | - | 5 | - | mV |
| OFF Isolation | (Note 4) | 25 | 75 | 80 | - | - | 80 | - | dB |
| Crosstalk | (Note 4) | 25 | -80 | -88 | - | - | -88 | - | dB |
| Input Switch Capacitance, $\mathrm{C}_{\mathrm{S} \text { (OFF) }}$ |  | 25 | - | 11 | - | - | 11 | - | pF |
| Output Switch Capacitance, $\mathrm{C}_{\mathrm{D} \text { (OFF) }}$ |  | 25 | - | 11 | - | - | 11 | - | pF |
| Output Switch Capacitance, $\mathrm{C}_{\mathrm{D}(\mathrm{ON})}$ |  | 25 | - | 22 | - | - | 22 | - | pF |
| Digital Input Capacitance, $\mathrm{C}_{\mathrm{A}}$ |  | 25 | - | 5 | - | - | 5 | - | pF |
| Drain To Source Capacitance, $\mathrm{C}_{\text {DS(OFF) }}$ |  | 25 | - | 0.5 | - | - | 0.5 | - | pF |
| DIGITAL INPUT CHARACTERISTICS |  |  |  |  |  |  |  |  |  |
| Input Low Threshold, $\mathrm{V}_{\text {AL }}$ |  | Full | - | - | 0.8 | - | - | 0.8 | V |
| Input High Threshold, $\mathrm{V}_{\text {AH }}$ |  | Full | 2.4 | - | - | 2.4 | - | - | V |
| Input Leakage Current (High or Low), $\mathrm{I}_{\mathrm{A}}$ |  | Full | - | 0.01 | 1.0 | - | 0.01 | 1.0 | $\mu \mathrm{A}$ |
| ANALOG SWITCH CHARACTERISTICS |  |  |  |  |  |  |  |  |  |
| Analog Signal Range |  | Full | -15 | - | +15 | -15 | - | +15 | V |
| ON Resistance, ron HI-5042 to HI-5047 | (Note 2) | 25 | - | 50 | 75 | - | 50 | 75 | $\Omega$ |
|  |  | Full | - | - | 150 | - | - | 150 | $\Omega$ |
| HI-5049, HI-5051 | (Note 2) | 25 | - | 25 | 45 | - | 25 | 45 | $\Omega$ |
|  |  | Full | - | - | 50 | - | - | 50 | $\Omega$ |
| Channel-to-Channel Match, $\Delta \mathrm{r}_{\mathrm{ON}}$ HI-5042 to HI-5047 |  | 25 | - | 2 | 10 | - | 2 | 10 | $\Omega$ |
| HI-5049, HI-5051 |  | 25 | - | 1 | 5 | - | 1 | 5 | $\Omega$ |

## Electrical Specifications

Supplies $=+15 \mathrm{~V},-15 \mathrm{~V} ; \mathrm{V}_{\mathrm{R}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{AH}}($ Logic Level High $)=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{AL}}$ (Logic Level Low) $=0.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{L}}=5 \mathrm{~V}$, Unless Otherwise Specified. For Test Conditions, Consult Performance Characteristics, Unused Pins are Grounded (Continued)

| PARAMETER | TEST CONDITIONS | $\begin{aligned} & \text { TEMP } \\ & \left({ }^{\circ} \mathrm{C}\right) \end{aligned}$ | -2 |  |  | -5, -9 |  |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | TYP | MAX |  |
| OFF Input or Output Leakage Current, $I_{S(O F F)}=I_{D(O F F)}$ |  | 25 | - | 0.8 | 2 | - | 0.8 | 2 | nA |
|  |  | Full | - | 100 | 200 | - | 100 | 200 | nA |
| ON Leakage Current, $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ |  | 25 | - | 0.01 | 2 | - | 0.01 | 2 | nA |
|  |  | Full | - | 2 | 200 | - | 2 | 200 | nA |
| POWER REQUIREMENTS |  |  |  |  |  |  |  |  |  |
| Quiescent Power Dissipation, $\mathrm{P}_{\mathrm{D}}$ |  | 25 | - | 1.5 | - | - | 1.5 | - | mW |
| $\mathrm{I}+, \mathrm{I}-, \mathrm{I}_{\mathrm{L}}, \mathrm{I}_{\mathrm{R}}$ |  | 25 | - | - | 0.2 | - | - | 0.3 | mA |
| I+, +15V Quiescent Current | (Note 5) | Full | - | - | 0.3 | - | - | 0.5 | mA |
| I-, -15V Quiescent Current | (Note 5) | Full | - | - | 0.3 | - | - | 0.5 | mA |
| $\mathrm{I}_{\mathrm{L},}+5 \mathrm{~V}$ Quiescent Current | (Note 5) | Full | - | - | 0.3 | - | - | 0.5 | mA |
| $\mathrm{I}_{\mathrm{R}}$, Ground Quiescent Current | (Note 5) | Full | - | - | 0.3 | - | - | 0.5 | mA |

NOTES:
2. $\mathrm{V}_{\text {OUT }}= \pm 10 \mathrm{~V}, \mathrm{I}_{\text {OUT }}=\mp 1 \mathrm{~mA}$.
3. $\mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}, \mathrm{C}_{\mathrm{L}}=10 \mathrm{nF}$.
4. $R_{L}=100 \Omega, f=100 \mathrm{kHz}, \mathrm{V}_{\mathrm{IN}}=2.0 \mathrm{~V}_{\mathrm{P}-\mathrm{P}}, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$.
5. $\mathrm{V}_{\mathrm{AL}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=5 \mathrm{~V}$.

Test Circuits and Waveforms
$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}+=+15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{L}}=+5 \mathrm{~V}, \mathrm{~V}_{\mathrm{R}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=3 \mathrm{~V}$ and $\mathrm{V}_{\mathrm{AL}}=0.8 \mathrm{~V}$ Unless Otherwise Specified


FIGURE 1A. TEST CIRCUIT


FIGURE 1B. ON RESISTANCE vs ANALOG SIGNAL LEVEL


FIGURE 1C. NORMALIZED ON RESISTANCE vs TEMPERATURE FIGURE 1. ON RESISTANCE

## Test Circuits and Waveforms $\quad \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}+=+15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{L}}=+5 \mathrm{~V}, \mathrm{~V}_{\mathrm{R}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=3 \mathrm{~V}$ and $\mathrm{V}_{\mathrm{AL}}=0.8 \mathrm{~V}$ Unless Otherwise Specified (Continued)



FIGURE 2A. LEAKAGE CURRENTS vs TEMPERATURE

OFF LEAKAGE CURRENT


FIGURE 2B. TEST CIRCUITS

FIGURE 2. LEAKAGE CURRENTS


FIGURE 3A. NORMALIZED ON RESISTANCE vs ANALOG CURRENT

FIGURE 3. NORMALIZED ON RESISTANCE


FIGURE 4A. OFF ISOLATION vs FREQUENCY


OFF ISOLATION $=20 \log \left(\frac{\mathrm{~V}_{\mathrm{IN}}}{\mathrm{V}_{\mathrm{OUT}}}\right)$

FIGURE 4B. TEST CIRCUIT

FIGURE 4C. OFF ISOLATION

Test Circuits and Waveforms $\quad \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}+=+15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{L}}=+5 \mathrm{~V}, \mathrm{~V}_{\mathrm{R}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=3 \mathrm{~V}$ and $\mathrm{V}_{\mathrm{AL}}=0.8 \mathrm{~V}$ Unless Otherwise Specified (Continued)



CROSSTALK $=20 \log \left(\frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{V}_{\mathrm{IN}}}\right)$

FIGURE 5A. CROSSTALK vs FREQUENCY
FIGURE 5B. TEST CIRCUIT
FIGURE 5. CROSSTALK


FIGURE 6A. POWER CONSUMPTION vs FREQUENCY


FIGURE 6B. TEST CIRCUIT
FIGURE 6. POWER CONSUMPTION


FIGURE 7A. TEST CIRCUIT


FIGURE 7B. MEASUREMENT POINTS

Test Circuits and Waveforms $T_{A}=25^{\circ} \mathrm{C}, \mathrm{V}+=+15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{L}}=+5 \mathrm{~V}, \mathrm{~V}_{\mathrm{R}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=3 \mathrm{~V}$ and $\mathrm{V}_{\mathrm{AL}}=0.8 \mathrm{~V}$ Unless Otherwise Specified (Continued)

$\mathrm{V}_{\mathrm{A}}=0 \mathrm{~V}$ to 5 V
Vertical: 2V/Div.
Horizontal: 200ns/Div.
FIGURE 7C. WAVEFORMS WITH TTL COMPATIBLE LOGIC INPUT


FIGURE 7E. SWITCHING TIMES vs POSITIVE DIGITAL VOLTAGE

$\mathrm{V}_{\mathrm{A}}=0 \mathrm{~V}$ to 10 V
Vertical: 5V/Div.
Horizontal: 200ns/Div.
FIGURE 7D. WAVEFORMS WITH CMOS COMPATIBLE LOGIC INPUT


FIGURE 7F. SWITCHING TIMES vs NEGATIVE DIGITAL VOLTAGE

FIGURE 7. SWITCH ton AND toff

Revision History The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

| DATE | REVISION | CHANGE |
| :---: | :---: | :--- |
| June 16, 2016 | FN3127.7 | Updated Ordering Information table on page 2. <br> Added Revision History and About Intersil sections. <br> Updated POD M16.15 to the latest revision changes are as follows: <br> Remove "u" symbol from drawing (overlaps the "a" on Side View). Multiple changes were made to <br> table. |

## About Intersil

Intersil Corporation is a leading provider of innovative power management and precision analog solutions. The company's products address some of the largest markets within the industrial and infrastructure, mobile computing and high-end consumer markets.

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## Dual-In-Line Plastic Packages (PDIP)


-B-


NOTES:

1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
4. Dimensions $\mathrm{A}, \mathrm{A} 1$ and L are measured with the package seated in JEDEC seating plane gauge GS-3.
5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch ( 0.25 mm ).
6. $E$ and $\mathrm{e}_{\mathrm{A}}$ are measured with the leads constrained to be perpendicular to datum $-\mathrm{C}-$.
7. $e_{B}$ and $e_{C}$ are measured at the lead tips with the leads unconstrained. $\mathrm{e}_{\mathrm{C}}$ must be zero or greater.
8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch ( 0.25 mm ).
9. N is the maximum number of terminal positions.
10. Corner leads ( $1, \mathrm{~N}, \mathrm{~N} / 2$ and $\mathrm{N} / 2+1$ ) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of $0.030-0.045$ inch ( $0.76-1.14 \mathrm{~mm}$ ).

## Small Outline Plastic Packages (SOIC)



NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15 mm ( 0.006 inch) per side.
4. Dimension " $E$ " does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25 mm ( 0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. " L " is the length of terminal for soldering to a substrate.
7. " N " is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width " $B$ ", as measured 0.36 mm ( 0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61 mm ( 0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M16.15 (JEDEC MS-012-AC ISSUE C) 16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

| SYMBOL | INCHES |  | MILLIMETERS |  | NOTES |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |  |
| A | 0.0532 | 0.0688 | 1.35 | 1.75 | - |
| A1 | 0.0040 | 0.0098 | 0.10 | 0.25 | - |
| B | 0.013 | 0.020 | 0.33 | 0.51 | 9 |
| C | 0.0075 | 0.0098 | 0.19 | 0.25 | - |
| D | 0.3859 | 0.3937 | 9.80 | 10.00 | 3 |
| E | 0.1497 | 0.1574 | 3.80 | 4.00 | 4 |
| e | 0.050 BSC |  | 1.27 BSC |  | - |
| H | 0.2284 | 0.2440 | 5.80 | 6.20 | - |
| h | 0.0099 | 0.0196 | 0.25 | 0.50 | 5 |
| L | 0.016 | 0.050 | 0.40 | 1.27 | 6 |
| N | 16 |  | 16 |  | 7 |
| $\alpha$ | $0^{\circ}$ | $8^{\circ}$ | $0^{\circ}$ | $8^{\circ}$ | - |

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## Ceramic Dual-In-Line Frit Seal Packages (CERDIP)



F16.3 MIL-STD-1835 GDIP1-T16 (D-2, CONFIGURATION A) 16 LEAD CERAMIC DUAL-IN-LINE FRIT SEAL PACKAGE

| SYMBOL | INCHES |  | MILLIMETERS |  | NOTES |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |  |
| A | - | 0.200 | - | 5.08 | - |
| b | 0.014 | 0.026 | 0.36 | 0.66 | 2 |
| b1 | 0.014 | 0.023 | 0.36 | 0.58 | 3 |
| b2 | 0.045 | 0.065 | 1.14 | 1.65 | - |
| b3 | 0.023 | 0.045 | 0.58 | 1.14 | 4 |
| c | 0.008 | 0.018 | 0.20 | 0.46 | 2 |
| c1 | 0.008 | 0.015 | 0.20 | 0.38 | 3 |
| D | - | 0.840 | - | 21.34 | 5 |
| E | 0.220 | 0.310 | 5.59 | 7.87 | 5 |
| e | 0.10 | SC |  | BSC | - |
| eA | 0.30 | SC |  | BSC | - |
| eA/2 | 0.15 | SC |  | BSC | - |
| L | 0.125 | 0.200 | 3.18 | 5.08 | - |
| Q | 0.015 | 0.060 | 0.38 | 1.52 | 6 |
| S1 | 0.005 | - | 0.13 | - | 7 |
| $\alpha$ | $90^{\circ}$ | $105^{\circ}$ | $90^{\circ}$ | $105^{\circ}$ | - |
| aaa | - | 0.015 | - | 0.38 | - |
| bbb | - | 0.030 | - | 0.76 | - |
| CCC | - | 0.010 | - | 0.25 | - |
| M | - | 0.0015 | - | 0.038 | 2, 3 |
| N | 16 |  | 16 |  | 8 |

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FSA3051TMX NLAS4684FCTCG NLAS5223BLMNR2G NLVAS4599DTT1G NLX2G66DMUTCG 425541DB 425528R 099044FB NLAS5123MNR2G PI5A4599BCEX NLAS4717EPFCT1G PI5A3167CCEX SLAS3158MNR2G PI5A392AQE PI5A4157ZUEX PI5A3166TAEX FSA634UCX TC4066BP(N,F) DG302BDJ-E3 PI5A100QEX HV2605FG-G HV2301FG-G RS2117YUTQK10 RS2118YUTQK10 RS2227XUTQK10 ADG452BRZ-REEL7 MAX4066ESD+ MAX391CPE+ MAX4730EXT+T MAX314CPE+ BU4066BCFV-E2 MAX313CPE+ BU4S66G2-TR NLAS3158MNR2G NLASB3157MTR2G TS3A4751PWR NLAS4157DFT2G NLAS4599DFT2G NLAST4599DFT2G NLAST4599DTT1G DG300BDJ-E3 DG2503DB-T2-GE1 DG2502DB-T2-GE1
TC4W53FU(TE12L,F) 74HC2G66DC. 125 ADG619BRMZ-REEL ADG1611BRUZ-REEL7 LTC201ACN\#PBF 74LV4066DB,118
FSA2275AUMX

